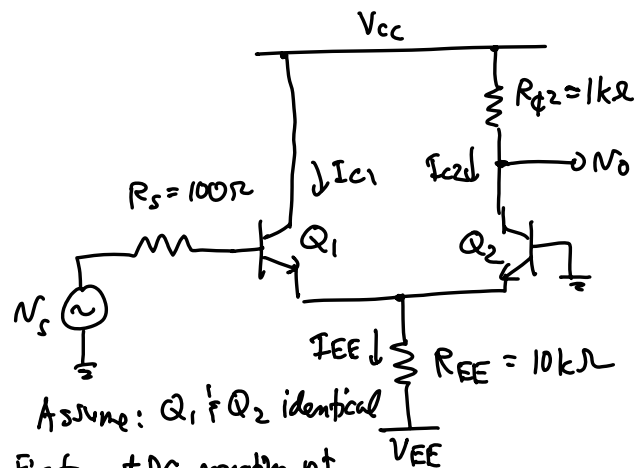


Inspection Analysis on a Multitransistor Ckt.



Assume:  $Q_1$  &  $Q_2$  identical

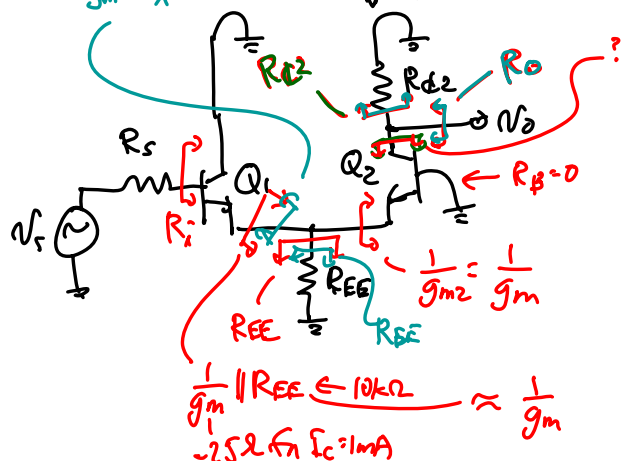
First, get DC operating pt.

$$I_{C1} = I_{C2} = \frac{I_{EE}}{2} \rightarrow r_{\pi 1} = r_{\pi 2} = r_{\pi}$$

$$r_{o1} = r_{o2} = r_o$$

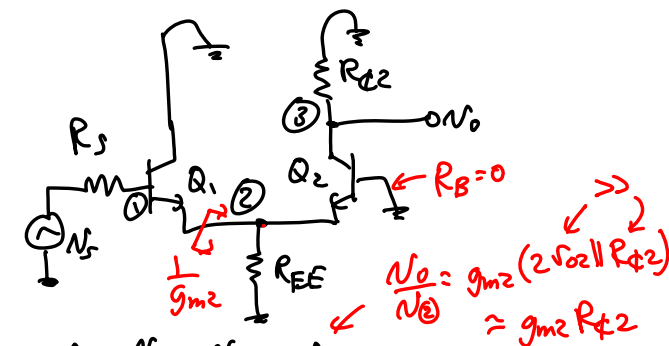
$$g_{m1} = g_{m2} = g_m$$

s.s. ac ckt.

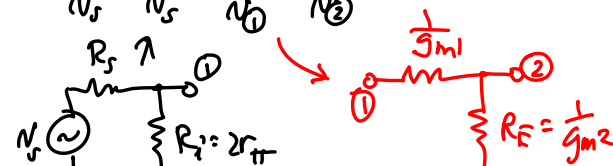


$$R_i = r_{\pi 1} + (\beta + 1) \frac{1}{g_{m2}} = r_{\pi 1} + r_{\pi 2} = 2r_{\pi}$$

$$R_o = r_{o2} \left( 1 + \frac{g_{m2} \left( \frac{1}{g_{m1}} \right)}{1 + 0} \right) \parallel R_{Q2} = (2r_o) \parallel R_{Q2} \approx R_{Q2}$$



$$\frac{N_o}{N_s} = \frac{N_o}{N_s} \cdot \frac{N_o}{N_o} \cdot \frac{N_o}{N_o}$$

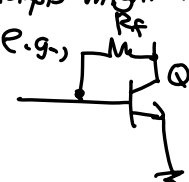


$$\frac{N_o}{N_s} = \frac{2r_{\pi}}{R_s + 2r_{\pi}}$$

$$\frac{N_o}{N_o} = \frac{\frac{1}{g_{m2}}}{\frac{1}{g_{m1}} + \frac{1}{g_{m2}}} = \frac{1}{2}$$

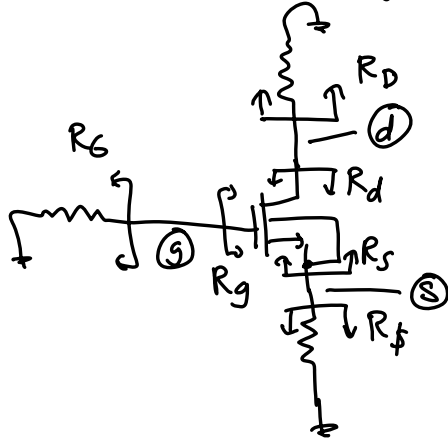
$$\frac{N_o}{N_s} = \left( \frac{2r_{\pi}}{R_s + 2r_{\pi}} \right) \frac{1}{2} g_m R_{Q2}$$

Inspection analysis might not work when there is feedback: e.g.,



Mos Xsistor Clkt.

⇒ for now, ignore Body effect (i.e., ignore  $g_{mb}$ )  
⇒ use the same inspection formulas as bipolar,  
but use  $\beta \rightarrow \infty$ ,  $r_{\pi} = \frac{\beta}{g_m} \rightarrow \infty$



⇒ referring to the "Inspection Formula Sheet":

Bipolar

$$R_b = \left( \frac{1}{g_m} + R_E \right) (\beta + 1) \xrightarrow{\beta \rightarrow \infty} R_g = \infty$$

$$R_e = \frac{1}{g_m} + \frac{R_B}{\beta + 1} \xrightarrow{\beta \rightarrow \infty} R_s = \frac{1}{g_m}$$

$$R_c = r_o \left[ 1 + \frac{g_m R_E}{1 + R_B / r_{\pi}} \right] \xrightarrow{\beta \rightarrow \infty} R_d = r_o [1 + g_m R_s]$$

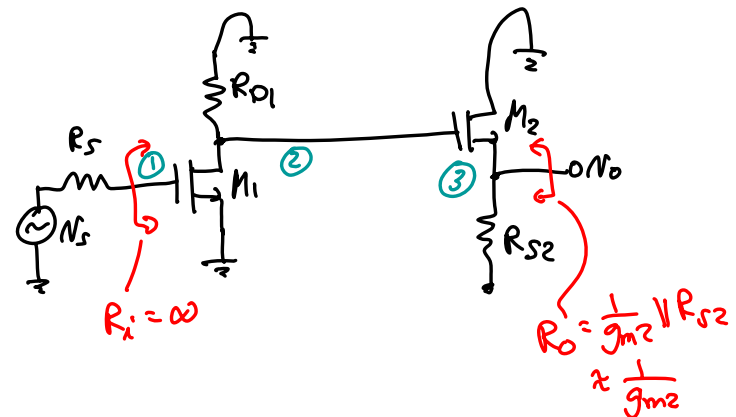
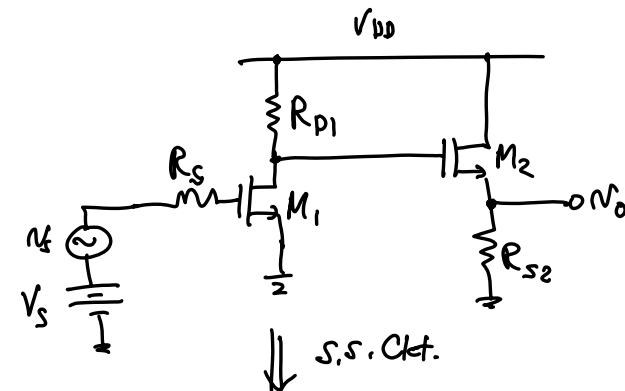
$$\frac{V_d}{V_s} = -G_m R_d, \quad G_m = \frac{g_m}{1 + g_m R_s}$$

$$\frac{V_d}{V_s} = -G_m R_d, \quad G_m = -g_m$$

$$\frac{V_s}{V_o} = \frac{g_m R_s}{1 + g_m R_s} = \frac{R_s}{\frac{1}{g_m} + R_s}$$

MOS Inspection Analysis

Ex: Common-Source Common-Drain Cascode



$$\frac{V_o}{V_i} = \frac{V_{o1}}{V_i} \cdot \frac{V_{o2}}{V_{o1}} \cdot \frac{V_o}{V_{o2}} \quad r_{o1} \parallel R_{D1} \approx R_{D1}$$

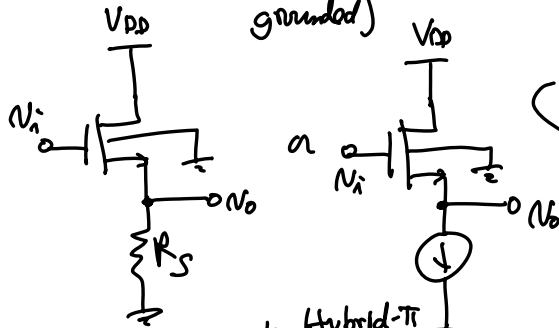
$$\frac{V_o}{V_i} = (1)(-g_{m1} R_{D1}) \left( \frac{R_{S2}}{\frac{1}{g_{m2}} + R_{S2}} \right)$$

Problem: Simulate in SPICE  $\rightarrow$  the gain will be from 80-90% of what you calculate!

$\rightarrow$  the problem is w/  $g_{mb}$  in the source follower!

$\nwarrow$  this is one difference between bipolar & MOS hybrid- $\pi$  models!

Source Follower: (w/ substrate grounded)



due to Body effect:  
 $V_{th} = V_{to} + \gamma(-)$